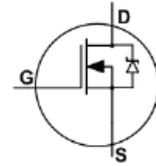


### Features

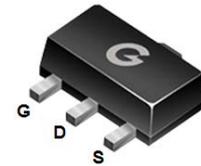
- Depletion mode (Normally On)
- Proprietary advanced planar technology
- Low leakage Current

HF



- **Applications**

- Transient protect
- Converters



- **Mechanical Data**

- Case: SOT-89
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208

SOT-89

### Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
BL4022	SOT-89	1000 pcs / Tape & Reel	4022

### Maximum Ratings (@ T<sub>A</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage <sup>*1</sup>	V <sub>DSX</sub>	400	V
Drain-to-Gate Voltage <sup>*1</sup>	V <sub>DGX</sub>	400	V
Gate-to-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current	I <sub>D</sub>	0.2	A
Pulsed Drain Current <sup>*2</sup>	I <sub>DM</sub>	0.8	A
Gate Source ESD <sup>*3</sup>	V <sub>ESD</sub>	3000	V
Source to Gate ESD <sup>*3</sup>		3000	V

### Thermal Characteristics

Parameter	Symbol	Value	Unit
Power Dissipation	P <sub>D</sub>	1	W
Thermal Resistance Junction-to-Case	R <sub>θJC</sub>	125	°C/W
Operating Junction Temperature Range	T <sub>J</sub>	-55 ~ +150	°C
Storage Temperature Range	T <sub>STG</sub>	-55 ~ +150	°C

### Electrical Characteristics (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
$BV_{DSX}$	Drain-to-Source Breakdown Voltage	$V_{GS} = -5V, I_D = 250\mu A$	400	-	-	V
$I_{D(OFF)}$	Drain-to-Source Leakage Current	$V_{DS} = 400V, V_{GS} = -5V$	-	-	1	$\mu A$
		$V_{DS} = 400V, V_{GS} = -5V, T_J = 125^\circ C$	-	-	1	mA
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	$\pm 5$	$\mu A$
<b>On Characteristics *4</b>						
$I_{DSS}$	Saturated Drain-to-Source Current	$V_{GS} = 0V, V_{DS} = 25V$	0.2	-	-	A
$R_{DS(ON)}$	Static Drain-Source On-resistance	$V_{GS} = 10V, I_D = 200mA$	-	-	23	$\Omega$
		$V_{GS} = 0V, I_D = 200mA$	-	-	25	$\Omega$
$V_{GS(OFF)}$	Gate-to-Source Cut-off Voltage	$V_{DS} = 3V, I_D = 8\mu A$	-3.3	-	-1.5	V
gfs	Forward Transconductance	$V_{DS} = 10V, I_D = 200mA$	-	193	-	mS
<b>Dynamic Characteristics</b>						
$C_{ISS}$	Input Capacitance	$V_{GS} = -5V$ $V_{DS} = 25V$ $f = 1.0MHz$	-	103.2	-	pF
$C_{OSS}$	Output Capacitance		-	17.7	-	
$C_{RSS}$	Reverse Transfer Capacitance		-	5.2	-	
<b>Switching Characteristics</b>						
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD} = 100V$ $V_{GS} = -5V \sim 5V$ $R_G = 10\Omega$ $I_D = 200mA$	-	6.6	-	ns
$t_r$	Turn-on Rise Time		-	9.2	-	
$t_{d(OFF)}$	Turn-Off Delay Time		-	18.8	-	
$t_f$	Turn-Off Fall Time		-	356	-	
$Q_G$	Total Gate-Charge	$V_{DD} = 100V$ $V_{GS} = -5V \sim 5V$ $I_D = 200mA$	-	359.6	-	nC
$Q_{GS}$	Gate to Source Charge		-	61.6	-	
$Q_{GD}$	Gate to Drain (Miller) Charge		-	130	-	
<b>Source-Drain Diode Characteristics</b>						
$V_{SD}$	Diode Forward Voltage *4	$I_{SD} = 200mA, V_{GS} = -10V$	-	-	1.5	V

Notes:

- $T_J = 25 \sim 150^\circ C$
- Repetitive rating, pulse width limited by maximum junction temperature
- The test is based on JEDEC EIA/JESD22-A114(HBM)
- Pulse width  $\leq 380\mu s$ ; duty cycle  $\leq 2\%$

Ratings and Characteristics Curves (@  $T_A = 25^\circ\text{C}$  unless otherwise specified)

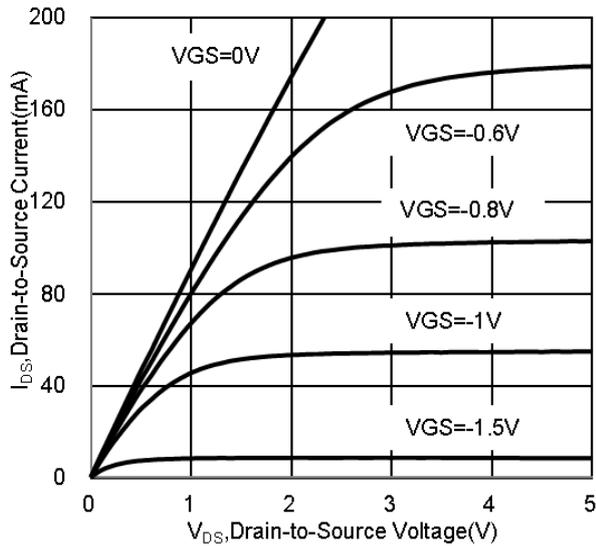


Fig 1 On-Region Characteristics

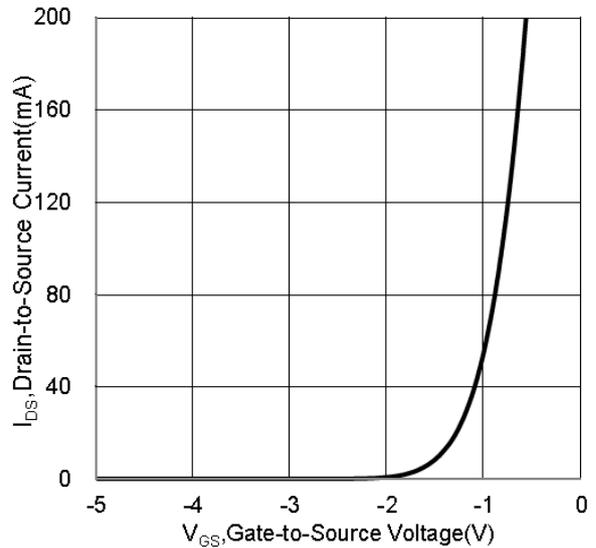


Fig 2 Transfer Characteristics

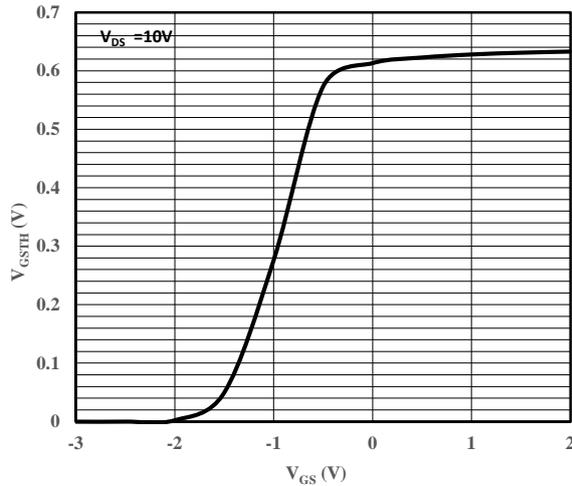


Fig 3 Transfer Characteristics

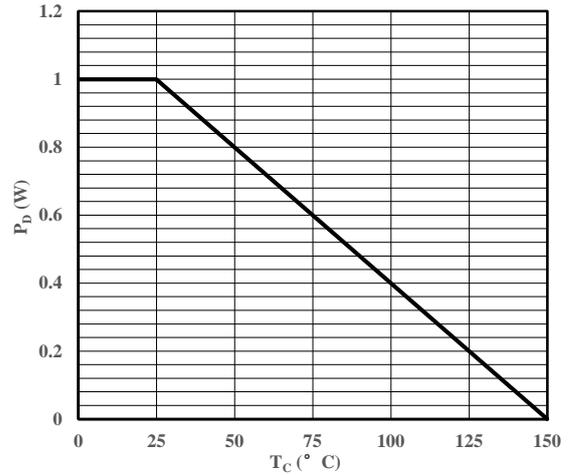
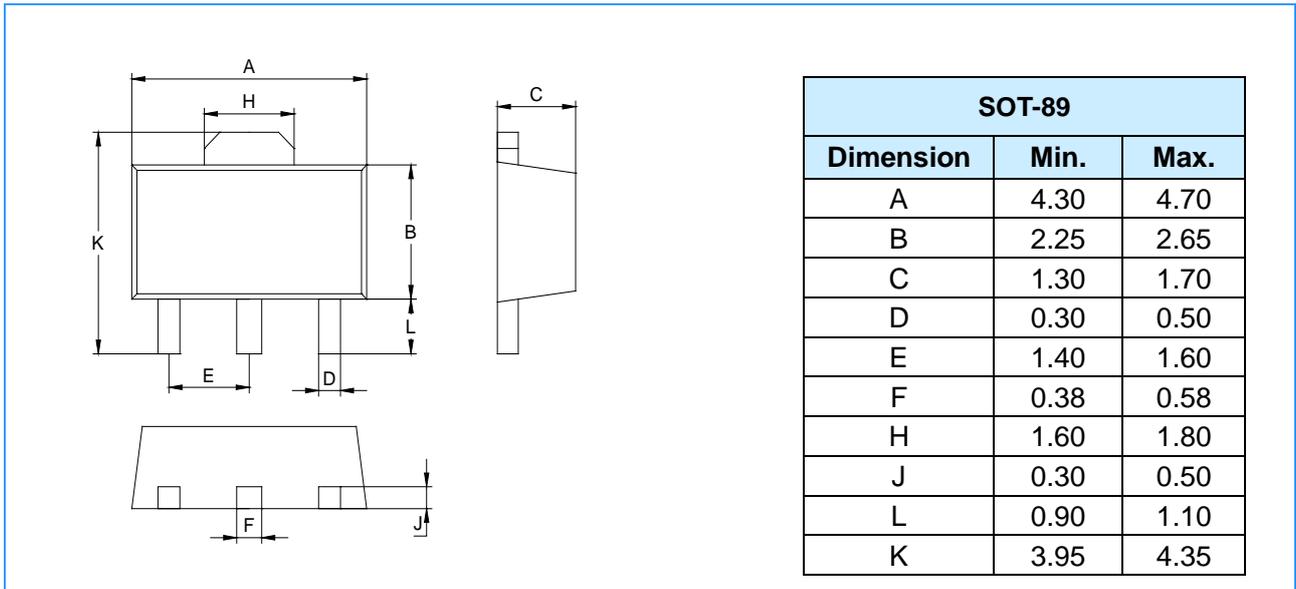
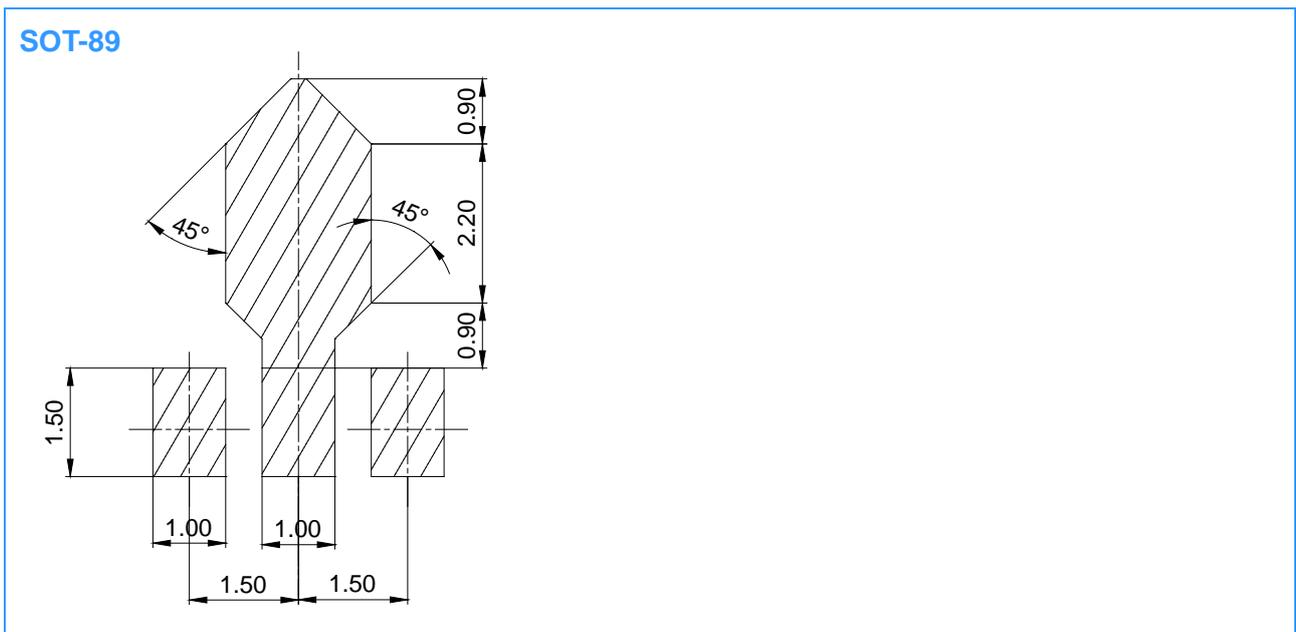


Fig 4 Power dissipation vs temp.

Package Outline Dimensions (Unit: mm)



Mounting Pad Layout (Unit: mm)



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